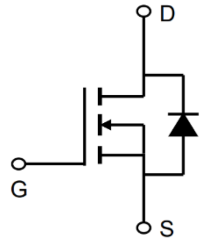
AP80N02NF

20V N-Channel Enhancement Mode MOSFET



Description

The AP80N02NF uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a Battery protection or in other Switching application.

General Features

V_{DS} = 20V I_D =80A

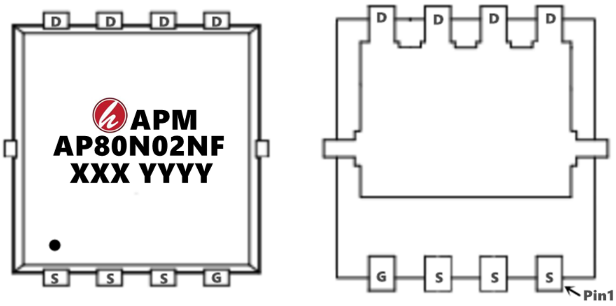
$R_{DS(ON)}$ < 3.5mΩ@ V_{GS}=4.5V (Type:2.8mΩ)

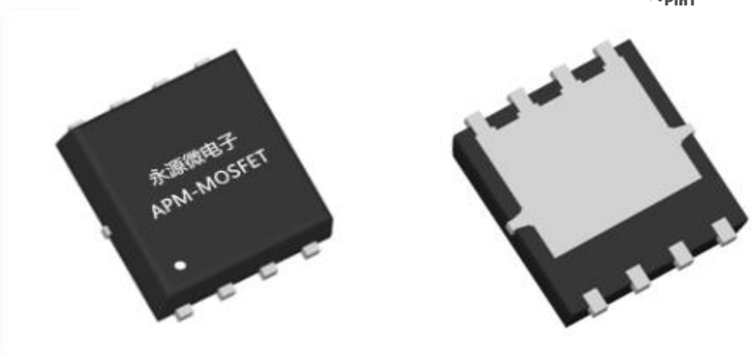
Application

solar road lights

Load switch

Uninterruptible power supply





Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
AP80N02NF	PDFN5*6-8L	AP80N02NF XXX YYYY	5000

Absolute Maximum Ratings (T_C=25℃unless otherwise noted)

Symbol	Parameter	Max.	Units
VDSS	Drain-Source Voltage	20	V
VGSS	Gate-Source Voltage	±12	V
I_D@T_C=25℃	Continuous Drain Current, V_{GS} @ 10V[1]	80	A
I_D@T_C=100℃	Continuous Drain Current, V_{GS} @ 10V[1]	59	A
IDM	Pulsed Drain Current [note1]	360	A
EAS	Single Pulsed Avalanche Energy [note2]	110	mJ
P_D	Power Dissipation	81	W
RθJA	Thermal Resistance, Junction to Case	65	℃/W
RθJC	Thermal Resistance Junction-Case 1	4	℃/W
TJ, TSTG	Operating and Storage Temperature Range	-55 to +175	℃

Electrical Characteristics (T_J=25 ℃, unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
BVDSS	Drain-Source Breakdown Voltage	V_{GS}=0V, I_D=250μA	20	24		V
△BVDSS/△TJ	BVDSS Temperature Coefficient	Reference to 25℃ , I_D=1mA	---	0.018	---	V/℃
VGS(th)	Gate Threshold Voltage	V_{DS}= V_{GS}, I_D=250μA	0.50	0.65	1.0	V
RDS(ON)	Static Drain-Source On-Resistance	V_{GS}=4.5V, I_D=30A		2.8	4.0	mΩ
RDS(ON)	Static Drain-Source On-Resistance	V_{GS}=2.5V, I_D=20A		4.0	6.0	
IDSS	Zero Gate Voltage Drain Current	V_{DS}=20V,V_{GS}=0V			1	μA
IGSS	Gate-Body Leakage Current	V_{GS}=±10V, V_{DS}=0V			±100	nA
C_{iss}	Input Capacitance	V_{DS}=10V,V_{GS}=0V,f=1MHZ		3200		pF
C_{oss}	Output Capacitance			460		
C_{rss}	Reverse Transfer Capacitance			446		
Q_g	Total Gate Charge	V_{GS}=4.5V,V_{DS}=10V,I_D=30A		11.05		nC
Q_{gs}	Gate-Source Charge			1.73		
Q_{gd}	Gate-Drain Charge			3.1		
tD(on)	Turn-on Delay Time	V_{GS}=4.5V, V_{DS}=10V, I_D=30A R_{GEN}=1.8Ω		9.7		ns
t_r	Turn-on Rise Time			37		
tD(off)	Turn-off Delay Time			63		
t_f	Turn-off fall Time			52		
V_{SD}	Diode Forward Voltage	I_S=7.6A,V_{GS}=0V			1.2	V

Note :

1、The data tested by surface mounted on a 1 inch^2 FR-4 board with 2OZ copper.
2、The data tested by pulsed , pulse width ≦ 300us , duty cycle ≦ 2%
3、The power dissipation is limited by 150℃ junction temperature
4、The data is theoretically the same as I_D and I_{DM} , in real applications , should be limited by total power dissipation.
5、EAS condition: TJ=25℃, VDD=15V, VG=4.5V, RG=25Ω, L=0.5mH, IAS=21A

Typical Characteristics

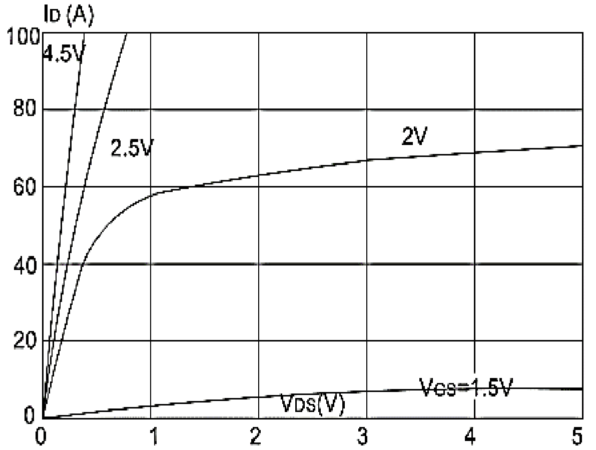


Figure1: Output Characteristics

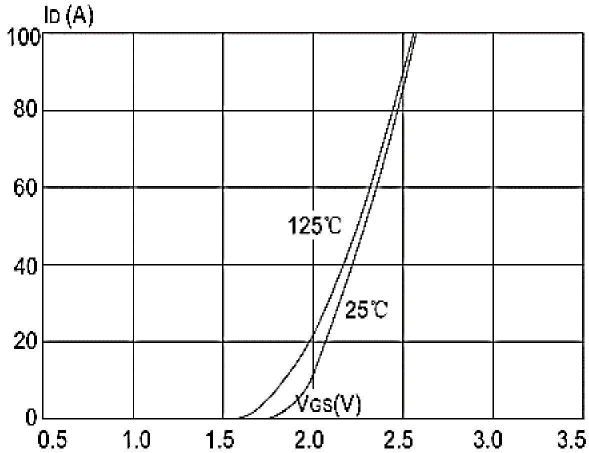


Figure 2: Typical Transfer Characteristics

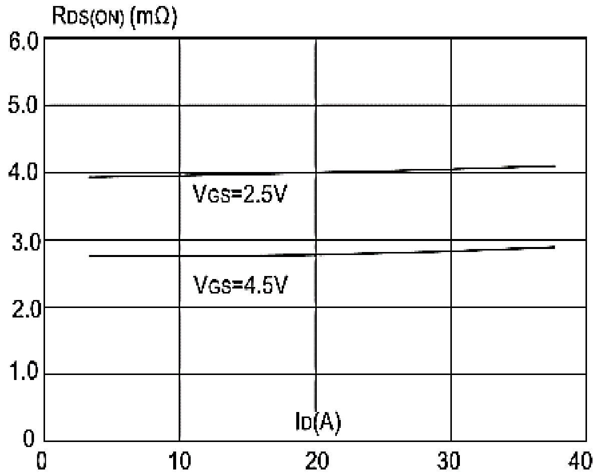


Figure 3:On-resistance vs. Drain Current

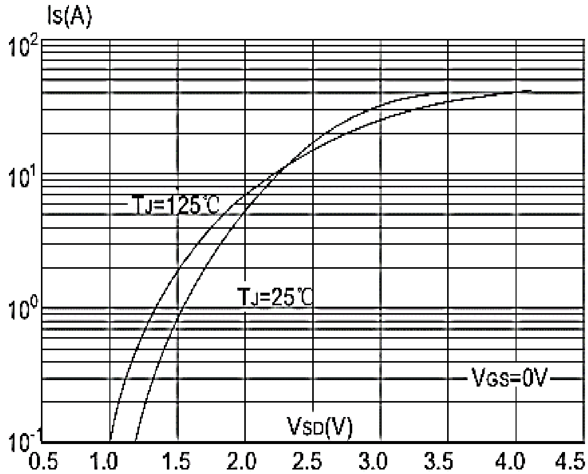


Figure 4: Body Diode Characteristics

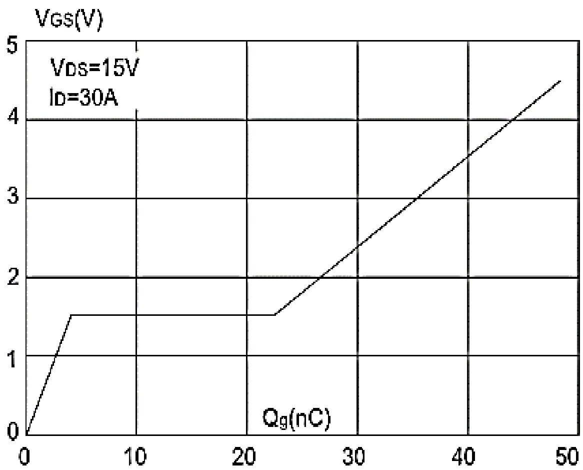


Figure 5: Gate Charge Characteristics

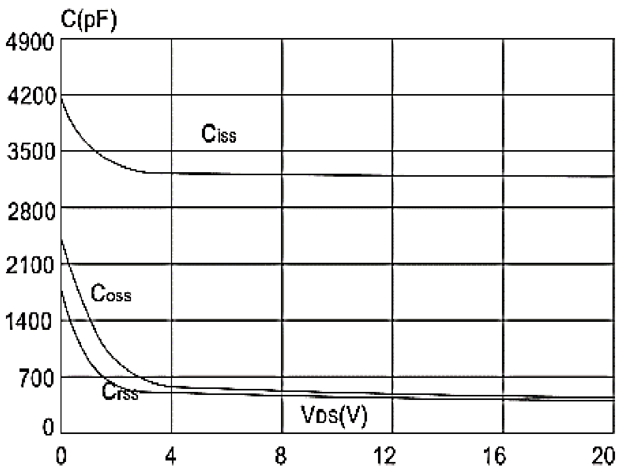


Figure 6: Capacitance Characteristics

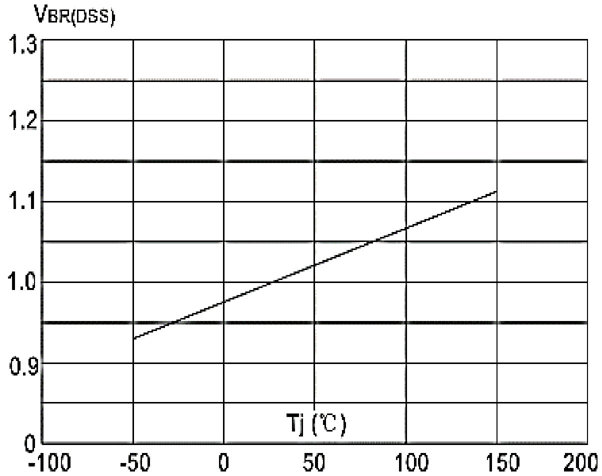


Figure 7: Normalized Breakdown Voltage vs Junction Temperature

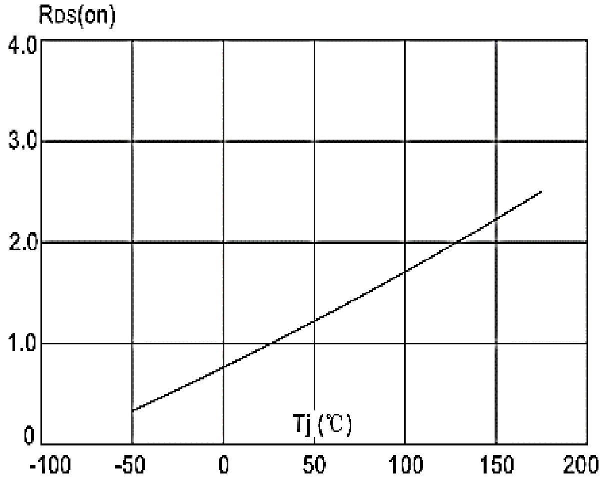


Figure 8: Normalized on Resistance vs. Junction Temperature

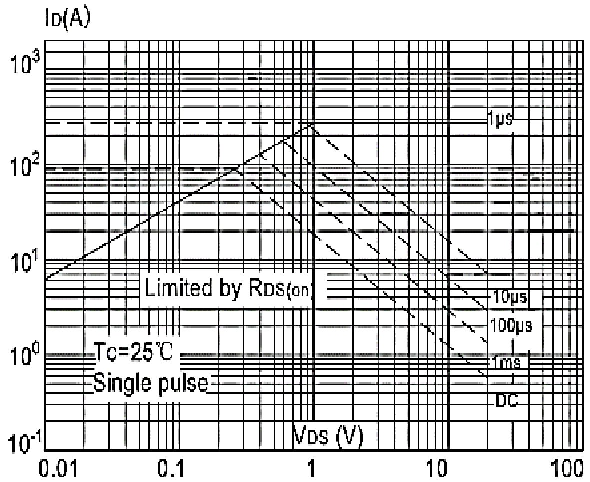


Figure 9: Maximum Safe Operating Area

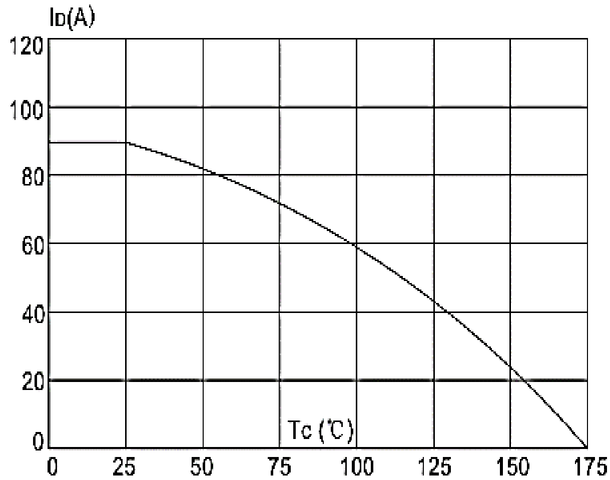


Figure 10: Maximum Continuous Drain Current vs. Ambient Temperature

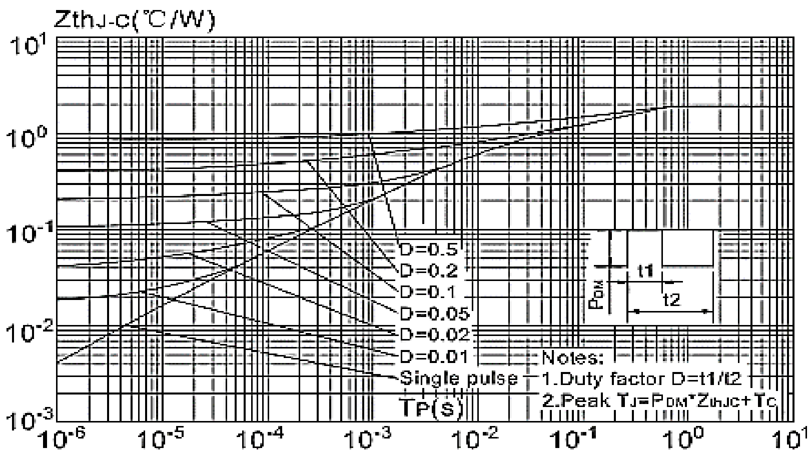
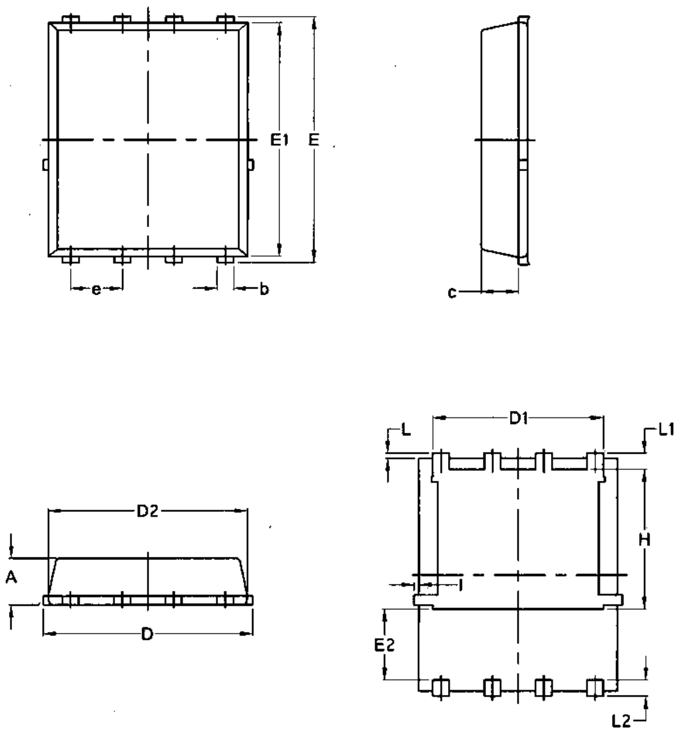


Figure.11: Maximum Effective Transient Thermal Impedance, Junction-to-Ambien

Package Mechanical Data-DFN5*6-8L-JQ Single



Symbol	Common			
	mm		Inch	
	Mim	Max	Min	Max
A	1.03	1.17	0.0406	0.0461
b	0.34	0.48	0.0134	0.0189
c	0.824	0.0970	0.0324	0.082
D	4.80	5.40	0.1890	0.2126
D1	4.11	4.31	0.1618	0.1697
D2	4.80	5.00	0.1890	0.1969
E	5.95	6.15	0.2343	0.2421
E1	5.65	5.85	0.2224	0.2303
E2	1.60	/	0.0630	/
e	1.27 BSC		0.05 BSC	
L	0.05	0.25	0.0020	0.0098
L1	0.38	0.50	0.0150	0.0197
L2	0.38	0.50	0.0150	0.0197
H	3.30	3.50	0.1299	0.1378
I	/	0.18	/	0.0070

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Edition	Date	Change
Rve1.0	2021/1/31	Initial release